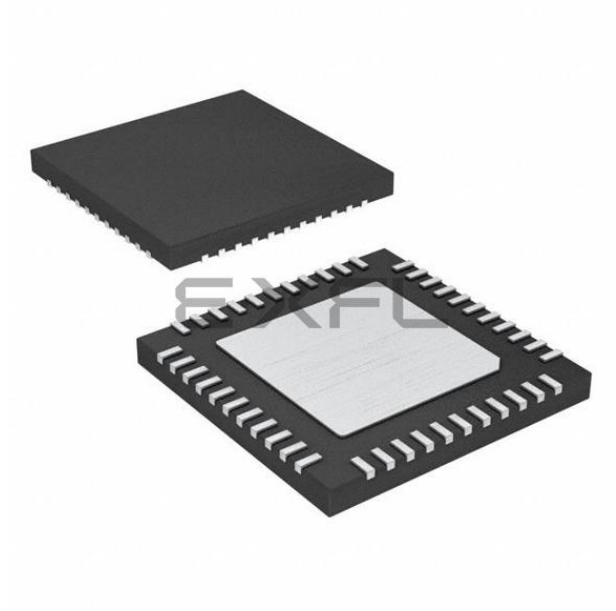

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Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	AVR
Core Size	8/16-Bit
Speed	32MHz
Connectivity	I²C, IrDA, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, POR, PWM, WDT
Number of I/O	34
Program Memory Size	64KB (32K x 16)
Program Memory Type	FLASH
EEPROM Size	2K x 8
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	1.6V ~ 3.6V
Data Converters	A/D 12x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	44-VFQFN Exposed Pad
Supplier Device Package	44-VQFN (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/atxmega64d4-mh

15. TC0/1 – 16-bit Timer/Counter Type 0 and 1

15.1 Features

- Four 16-bit timer/counters
  - Three timer/counters of type 0
  - One timer/counter of type 1
- 32-bit timer/counter support by cascading two timer/counters
- Up to four compare or capture (CC) channels
  - Four CC channels for timer/counters of type 0
  - Two CC channels for timer/counters of type 1
- Double buffered timer period setting
- Double buffered capture or compare channels
- Waveform generation:
  - Frequency generation
  - Single-slope pulse width modulation
  - Dual-slope pulse width modulation
- Input capture:
  - Input capture with noise cancelling
  - Frequency capture
  - Pulse width capture
  - 32-bit input capture
- Timer overflow and error interrupts/events
- One compare match or input capture interrupt/event per CC channel
- Can be used with event system for:
  - Quadrature decoding
  - Count and direction control
  - Capture
- High-resolution extension
  - Increases frequency and waveform resolution by 4x (2-bit) or 8x (3-bit)
- Advanced waveform extension:
  - Low- and high-side output with programmable dead-time insertion (DTI)
- Event controlled fault protection for safe disabling of drivers

15.2 Overview

Atmel AVR XMEGA devices have a set of four flexible 16-bit Timer/Counters (TC). Their capabilities include accurate program execution timing, frequency and waveform generation, and input capture with time and frequency measurement of digital signals. Two timer/counters can be cascaded to create a 32-bit timer/counter with optional 32-bit capture.

A timer/counter consists of a base counter and a set of compare or capture (CC) channels. The base counter can be used to count clock cycles or events. It has direction control and period setting that can be used for timing. The CC channels can be used together with the base counter to do compare match control, frequency generation, and pulse width waveform modulation, as well as various input capture operations. A timer/counter can be configured for either capture or compare functions, but cannot perform both at the same time.

A timer/counter can be clocked and timed from the peripheral clock with optional prescaling or from the event system. The event system can also be used for direction control and capture trigger or to synchronize operations.

There are two differences between timer/counter type 0 and type 1. Timer/counter 0 has four CC channels, and timer/counter 1 has two CC channels. All information related to CC channels 3 and 4 is valid only for timer/counter 0. Only Timer/Counter 0 has the split mode feature that split it into two 8-bit Timer/Counters with four compare channels each.

18. Hi-Res – High Resolution Extension

18.1 Features

- Increases waveform generator resolution up to 8x (three bits)
- Supports frequency, single-slope PWM, and dual-slope PWM generation
- Supports the AWeX when this is used for the same timer/counter

18.2 Overview

The high-resolution (hi-res) extension can be used to increase the resolution of the waveform generation output from a timer/counter by four or eight. It can be used for a timer/counter doing frequency, single-slope PWM, or dual-slope PWM generation. It can also be used with the AWeX if this is used for the same timer/counter.

The hi-res extension uses the peripheral 4x clock (Clk_{PER4}). The system clock prescalers must be configured so the peripheral 4x clock frequency is four times higher than the peripheral and CPU clock frequency when the hi-res extension is enabled.

There is one hi-res extension that can be enabled for each timer/counter on PORTC. The notation of this is HIRESC.

29. Peripheral Module Address Map

The address maps show the base address for each peripheral and module in Atmel AVR XMEGA D4. For complete register description and summary for each peripheral module, refer to the XMEGA D manual.

Table 29-1. Peripheral Module Address Map

Base address	Name	Description
0x0000	GPIO	General purpose IO registers
0x0010	VPORT0	Virtual Port 0
0x0014	VPORT1	Virtual Port 1
0x0018	VPORT2	Virtual Port 2
0x001C	VPORT3	Virtual Port 2
0x0030	CPU	CPU
0x0040	CLK	Clock control
0x0048	SLEEP	Sleep controller
0x0050	OSC	Oscillator control
0x0060	DFLLRC32M	DFLL for the 32 MHz internal RC oscillator
0x0068	DFLLRC2M	DFLL for the 2 MHz RC oscillator
0x0070	PR	Power reduction
0x0078	RST	Reset controller
0x0080	WDT	Watch-dog timer
0x0090	MCU	MCU control
0x00A0	PMIC	Programmable multilevel interrupt controller
0x00B0	PORTCFG	Port configuration
0x0180	EVSYS	Event system
0x00D0	CRC	CRC module
0x01C0	NVM	Nonvolatile memory (NVM) controller
0x0200	ADCA	Analog to digital converter on port A
0x0380	ACA	Analog comparator pair on port A
0x0400	RTC	Real time counter
0x0480	TWIC	Two wire interface on port C
0x04A0	TWIE	Two wire interface on port E
0x0600	PORTA	Port A
0x0620	PORTB	Port B
0x0640	PORTC	Port C
0x0660	PORTD	Port D

2. EEPROM is not erased if the EESAVE fuse is programmed.

32.1.13 Clock and Oscillator Characteristics

32.1.13.1 Calibrated 32.768kHz Internal Oscillator Characteristics

Table 32-19. 32.768kHz Internal Oscillator Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
	Frequency			32.768		kHz
	Factory calibration accuracy	T = 85°C, V_{CC} = 3.0V	-0.5		0.5	%
	User calibration accuracy		-0.5		0.5	

32.1.13.2 Calibrated 2MHz RC Internal Oscillator Characteristics

Table 32-20. 2MHz Internal Oscillator Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
	Frequency range	DFLL can tune to this frequency over voltage and temperature	1.8		2.2	MHz
	Factory calibrated frequency			2.0		
	Factory calibration accuracy	T = 85°C, V_{CC}= 3.0V	-1.5		1.5	%
	User calibration accuracy		-0.2		0.2	
	DFLL calibration stepsize			0.18		

32.1.13.3 Calibrated and Tunable 32MHz Internal Oscillator Characteristics

Table 32-21. 32MHz Internal Oscillator Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
	Frequency range	DFLL can tune to this frequency over voltage and temperature	30	32	55	MHz
	Factory calibrated frequency			32		
	Factory calibration accuracy	T = 85°C, V_{CC}= 3.0V	-1.5		1.5	%
	User calibration accuracy		-0.2		0.2	
	DFLL calibration step size			0.19		

32.1.13.4 32kHz Internal ULP Oscillator Characteristics

Table 32-22. 32kHz Internal ULP Oscillator Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
	Factory calibrated frequency			32		kHz
	Factory calibration accuracy	T = 85°C, V_{CC}= 3.0V	-12		12	%
	Accuracy		-30		30	

32.2.13.7 External 16MHz Crystal Oscillator and XOSC Characteristics

Table 32-53. External 16MHz Crystal Oscillator and XOSC Characteristics

Symbol	Parameter	Condition		Min.	Typ.	Max.	Units
	Cycle to cycle jitter	XOSCPWR=0	FRQRANGE=0		0		ns
			FRQRANGE=1, 2, or 3		0		
		XOSCPWR=1			0		
	Long term jitter	XOSCPWR=0	FRQRANGE=0		0		
			FRQRANGE=1, 2, or 3		0		
		XOSCPWR=1			0		
	Frequency error	XOSCPWR=0	FRQRANGE=0		0.03		%
			FRQRANGE=1		0.03		
			FRQRANGE=2 or 3		0.03		
		XOSCPWR=1			0.003		
	Duty cycle	XOSCPWR=0	FRQRANGE=0		50		
			FRQRANGE=1		50		
			FRQRANGE=2 or 3		50		
		XOSCPWR=1			50		
R_Q	Negative impedance	XOSCPWR=0, FRQRANGE=0	0.4MHz resonator, CL=100pF		44k		Ω
			1MHz crystal, CL=20pF		67k		
			2MHz crystal, CL=20pF		67k		
		XOSCPWR=0, FRQRANGE=1, CL=20pF	2MHz crystal		82k		
			8MHz crystal		1500		
			9MHz crystal		1500		
		XOSCPWR=0, FRQRANGE=2, CL=20pF	8MHz crystal		2700		
			9MHz crystal		2700		
			12MHz crystal		1000		
		XOSCPWR=0, FRQRANGE=3, CL=20pF	9MHz crystal		3600		
			12MHz crystal		1300		
			16MHz crystal		590		

Table 32-67. Gain Stage Characteristics

Symbol	Parameter	Condition		Min.	Typ.	Max.	Units
R_{in}	Input resistance	Switched in normal mode			4.0		kΩ
C_{sample}	Input capacitance	Switched in normal mode			4.4		pF
	Signal range	Gain stage output		0		V_{CC}- 0.6	V
	Propagation delay	ADC conversion rate			1		Clk_{ADC} cycles
	Sample rate	Same as ADC		14		200	kHz
INL (1)	Integral non-linearity	50ksps	All gain settings		±1.5	±4	lsb
	Gain error	1x gain, normal mode			-0.8		%
		8x gain, normal mode			-2.5		
		64x gain, normal mode			-3.5		
	Offset error, output referred	1x gain, normal mode			-2		mV
		8x gain, normal mode			-5		
		64x gain, normal mode			-4		
	Noise	1x gain, normal mode	V_{CC} = 3.6V Ext. V_{REF}		0.5		mV rms
		8x gain, normal mode			1.5		
		64x gain, normal mode			11		

Note: 1. Maximum numbers are based on characterisation and not tested in production, and valid for 5% to 95% input voltage range.

32.3.7 Analog Comparator Characteristics

Table 32-68. Analog Comparator Characteristics

Symbol	Parameter	Condition		Min.	Typ.	Max.	Units
V_{off}	Input offset voltage				<±10		mV
I_{lk}	Input leakage current				<1		nA
	Input voltage range			-0.1		AV_{CC}	V
	AC startup time				100		µs
V_{hys1}	Hysteresis, none				0		mV
V_{hys2}	Hysteresis, small				13		
V_{hys3}	Hysteresis, large				30		
t_{delay}	Propagation delay	V_{CC} = 3.0V, T= 85°C	mode = HS		30	90	ns
					30		
	64-Level voltage scaler	Integral non-linearity (INL)			0.3	0.5	lsb

32.3.15 Two-Wire Interface Characteristics

Table 32-85 describes the requirements for devices connected to the Two-Wire Interface Bus. The Atmel AVR XMEGA Two-Wire Interface meets or exceeds these requirements under the noted conditions. Timing symbols refer to Figure 32-21.

Figure 32-21.Two-wire Interface Bus Timing

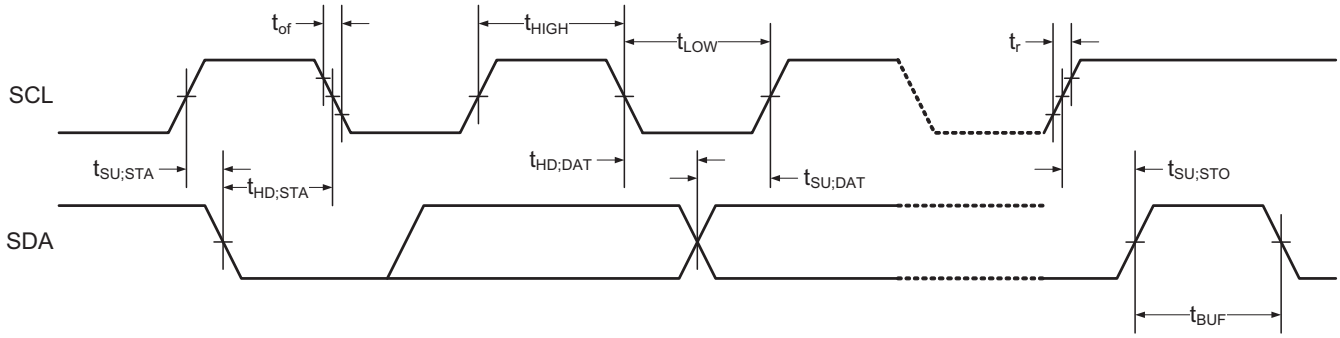


Table 32-85. Two-wire Interface Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
V_{IH}	Input high voltage		$0.7*V_{CC}$		$V_{CC}+0.5$	V
V_{IL}	Input low voltage		-0.5		$0.3*V_{CC}$	
V_{hys}	Hysteresis of Schmitt Trigger Inputs		$0.05*V_{CC}$ (1)			
V_{OL}	Output low voltage	3mA, sink current	0		0.4	
t_r	Rise time for both SDA and SCL		$20+0.1C_b$ (1)(2)		300	ns
t_{of}	Output fall time from V_{IHmin} to V_{ILmax}	$10pF < C_b < 400pF$ (2)	$20+0.1C_b$ (1)(2)		250	
t_{SP}	Spikes suppressed by input filter		0		50	
I_I	Input current for each I/O pin	$0.1V_{CC} < V_I < 0.9V_{CC}$	-10		10	µA
C_I	Capacitance for each I/O pin				10	pF
f_{SCL}	SCL clock frequency	f_{PER} (3)>max($10f_{SCL}$, 250kHz)	0		400	kHz
R_P	Value of pull-up resistor	$f_{SCL} \leq 100kHz$	$\frac{V_{CC}-0.4V}{3mA}$		$\frac{100ns}{C_b}$	Ω
		$f_{SCL} > 100kHz$			$\frac{300ns}{C_b}$	

32.4 ATxmega128D4

32.4.1 Absolute Maximum Ratings

Stresses beyond those listed in Table 32-86 under may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 32-86. Absolute Maximum Ratings

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
V_{CC}	Power supply voltage		-0.3		4	V
I_{VCC}	Current into a V_{CC} pin				200	mA
I_{GND}	Current out of a Gnd pin				200	
V_{PIN}	Pin voltage with respect to Gnd and V_{CC}		-0.5		V_{CC}+0.5	V
I_{PIN}	I/O pin sink/source current		-25		25	mA
T_A	Storage temperature		-65		150	°C
T_j	Junction temperature				150	

32.4.2 General Operating Ratings

The device must operate within the ratings listed in Table 32-87 in order for all other electrical characteristics and typical characteristics of the device to be valid.

Table 32-87. General Operating Conditions

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
V_{CC}	Power supply voltage		1.60		3.6	V
AV_{CC}	Analog supply voltage		1.60		3.6	
T_A	Temperature range		-40		85	°C
T_j	Junction temperature		-40		105	

Table 32-88. Operating Voltage and Frequency

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
Clk_{CPU}	CPU clock frequency	V_{CC} = 1.6V	0		12	MHz
		V_{CC} = 1.8V	0		12	
		V_{CC} = 2.7V	0		32	
		V_{CC} = 3.6V	0		32	

32.4.13.6 External Clock Characteristics

Figure 32-24.External Clock Drive Waveform

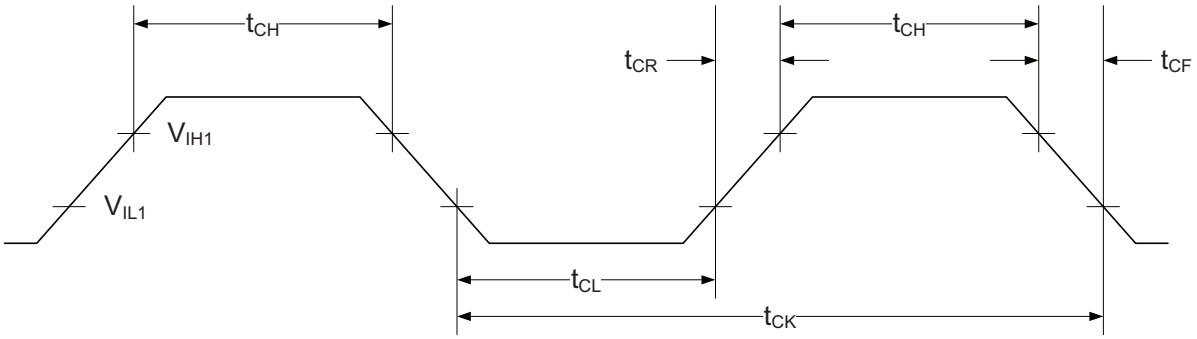


Table 32-109. External Clock Used as System Clock without Prescaling

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
$1/t_{CK}$	Clock frequency[1]	V_{CC} = 1.6 - 1.8V	0		12	MHz
		V_{CC} = 2.7 - 3.6V	0		32	
t_{CK}	Clock period	V_{CC} = 1.6 - 1.8V	83.3			ns
		V_{CC} = 2.7 - 3.6V	31.5			
t_{CH}	Clock high time	V_{CC} = 1.6 - 1.8V	30.0			
		V_{CC} = 2.7 - 3.6V	12.5			
t_{CL}	Clock low time	V_{CC} = 1.6 - 1.8V	30.0			
		V_{CC} = 2.7 - 3.6V	12.5			
t_{CR}	Rise time (for maximum frequency)	V_{CC} = 1.6 - 1.8V			10	
		V_{CC} = 2.7 - 3.6V			3	
t_{CF}	Fall time (for maximum frequency)	V_{CC} = 1.6 - 1.8V			10	
		V_{CC} = 2.7 - 3.6V			3	
Δt_{CK}	Change in period from one clock cycle to the next				10	%

Note: 1. System Clock Prescalers must be set so that maximum CPU clock frequency for device is not exceeded.

33.1.6 BOD Characteristics

Figure 33-55. BOD Thresholds vs. Temperature

BOD level = 1.6V

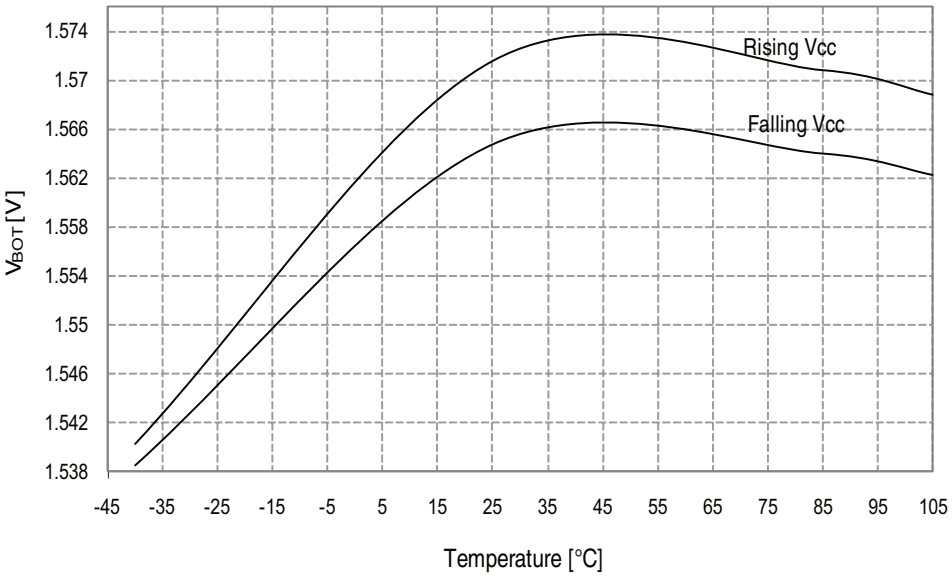


Figure 33-56. BOD Thresholds vs. Temperature

BOD level = 3.0V

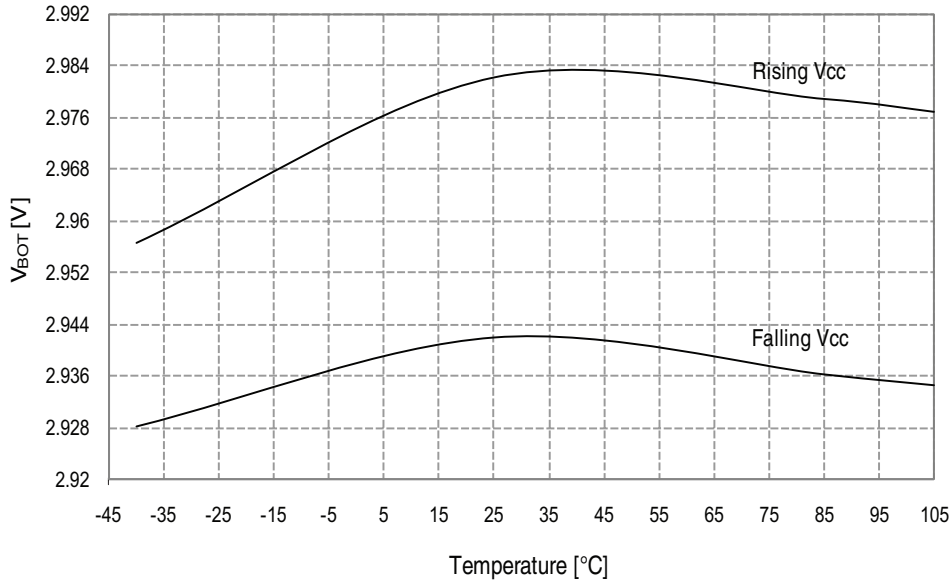


Figure 33-59. Reset Pin Pull-up Resistor Current vs. Reset Pin Voltage

V_{CC} = 3.0V

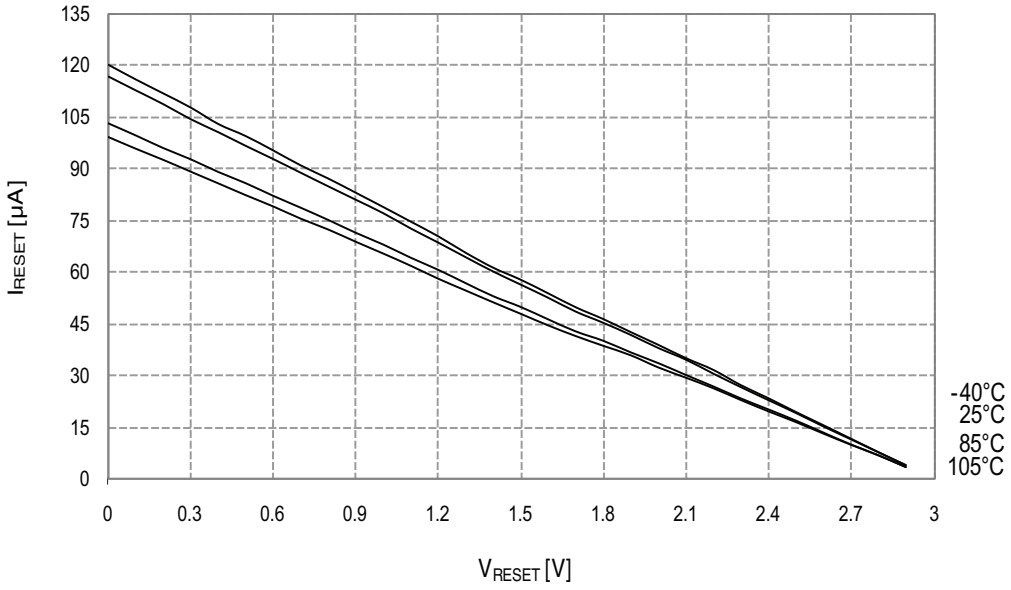


Figure 33-60. Reset Pin Pull-up Resistor Current vs. Reset Pin Voltage

V_{CC} = 3.3V

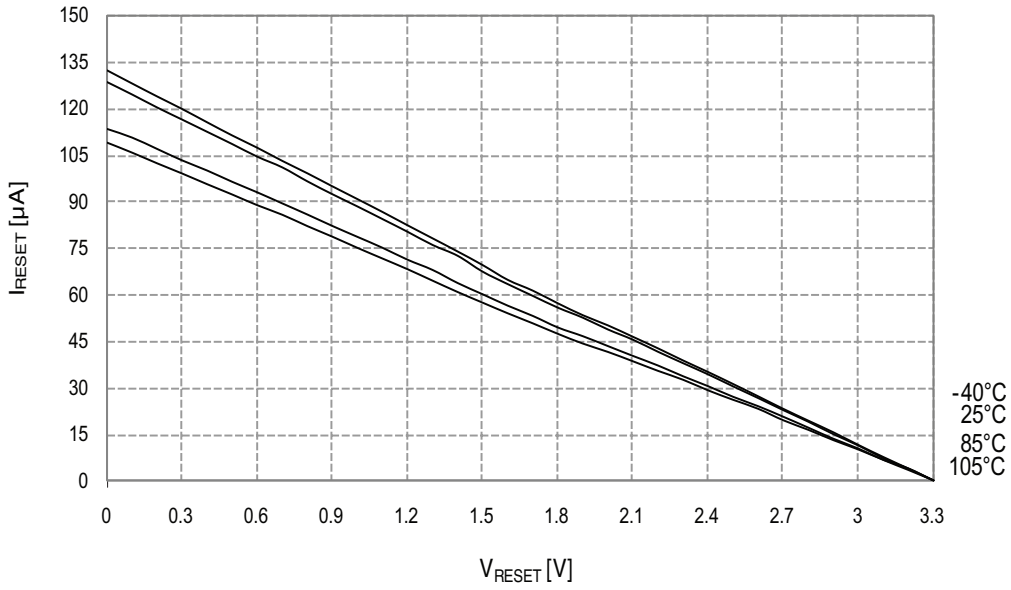


Figure 33-75. 48MHz Internal Oscillator Frequency vs. Temperature

DFLL enabled, from the 32.768kHz internal oscillator

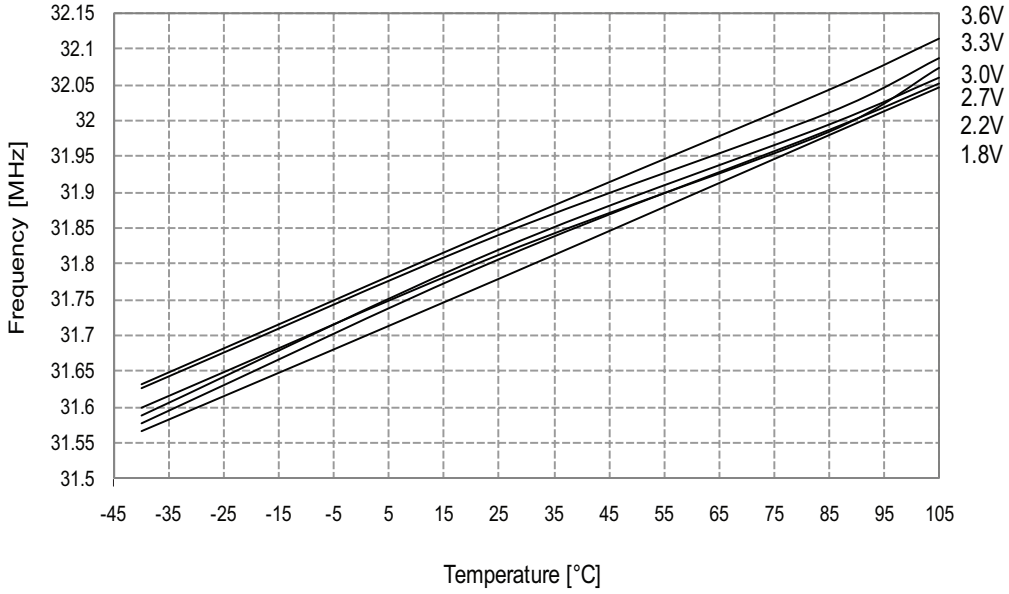


Figure 33-76. 48MHz Internal Oscillator CALA Calibration Step Size

V_{CC} = 3.0V

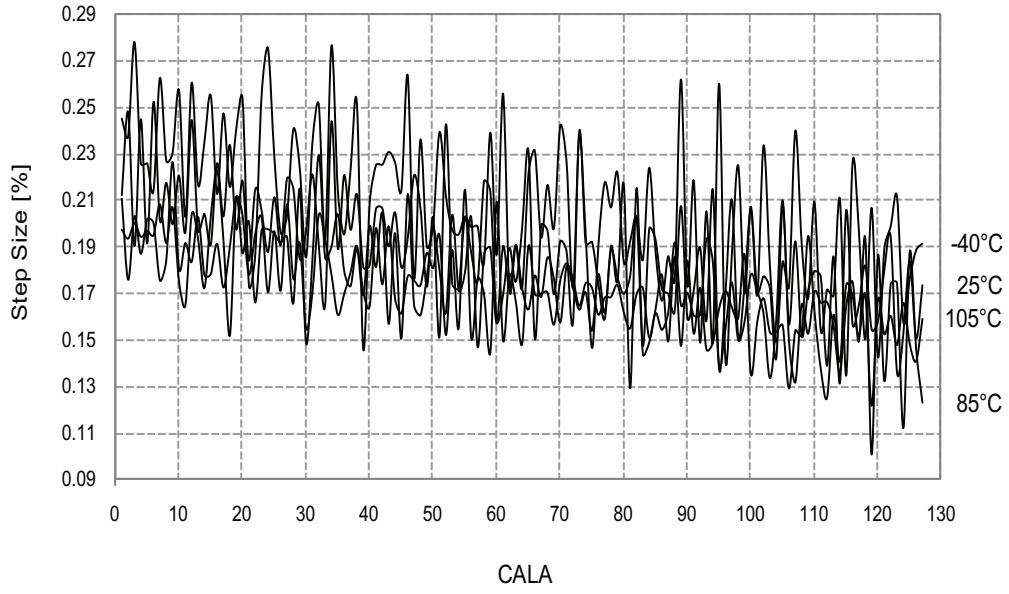


Figure 33-88. Idle Mode Supply Current vs. Frequency

f_{SYS} = 1 - 32MHz external clock, T = 25°C

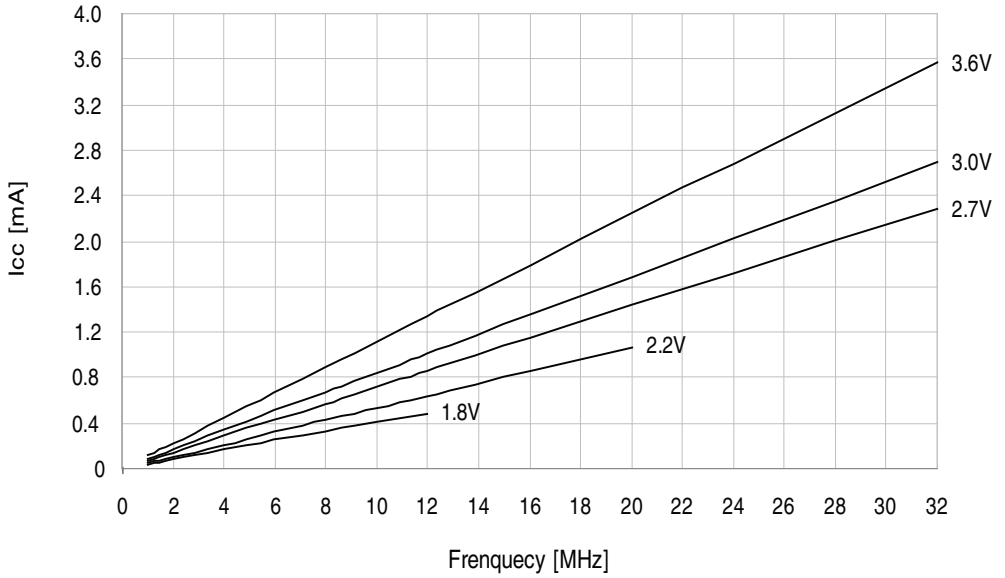


Figure 33-89. Idle Mode Supply Current vs. V_{CC}

f_{SYS} = 32.768kHz internal oscillator

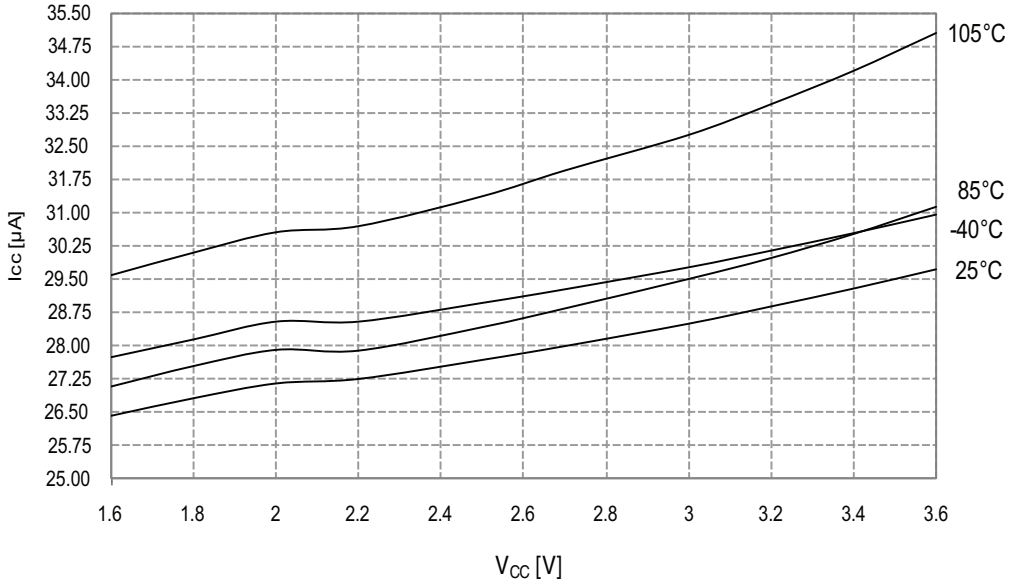
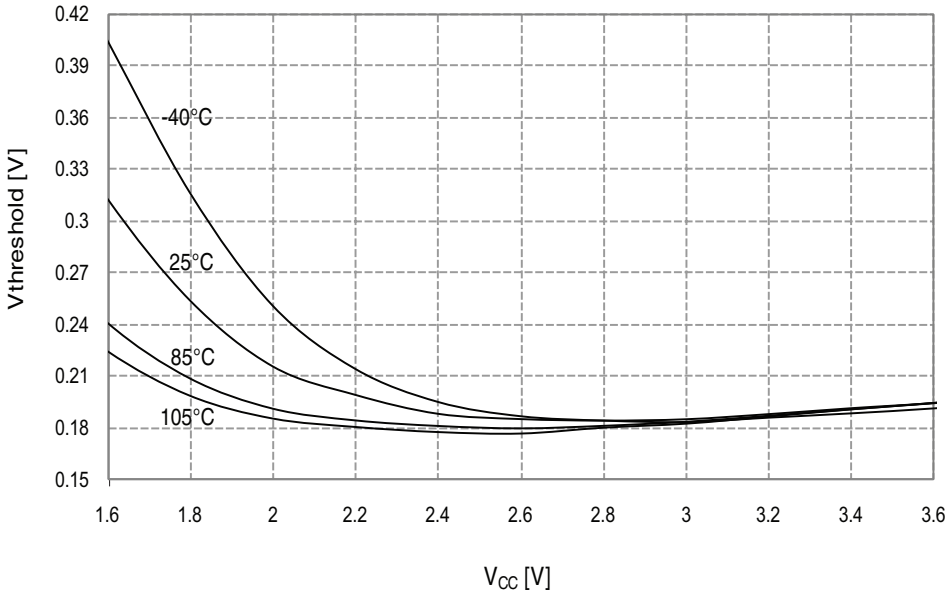


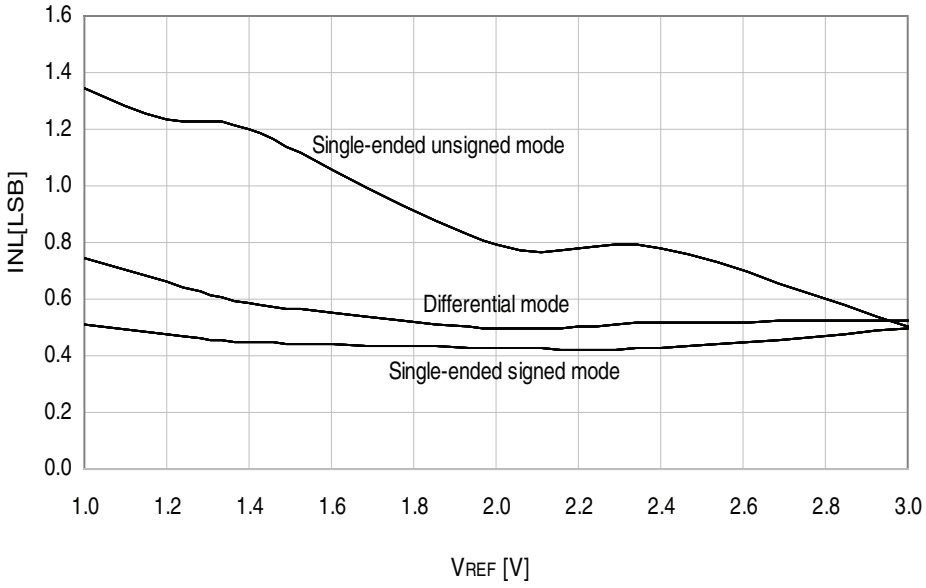
Figure 33-114. I/O Pin Input Hysteresis vs. V_{CC}



33.2.3 ADC Characteristics

Figure 33-115. INL Error vs. External V_{REF}

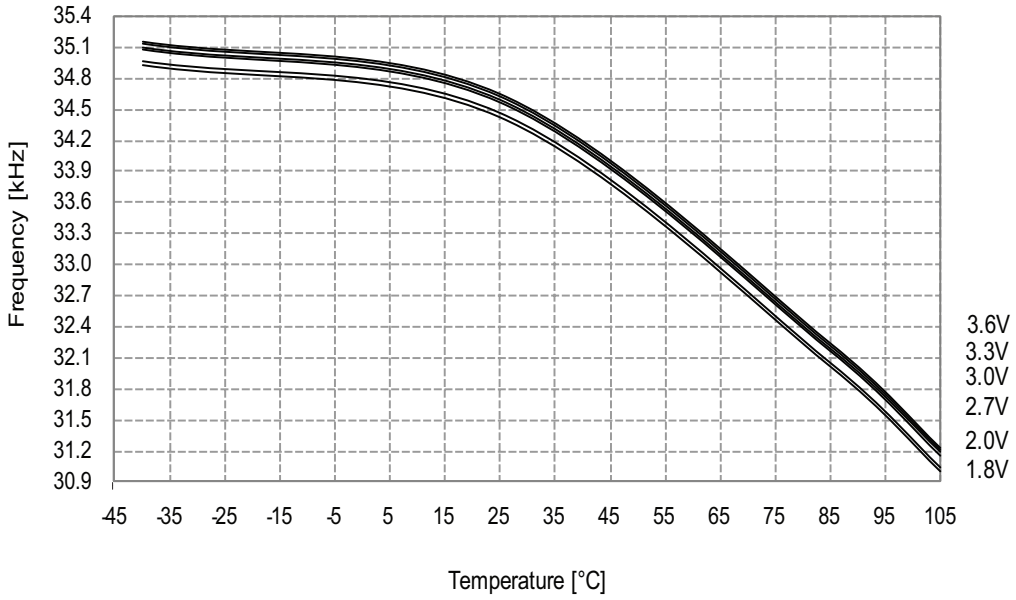
T = 25°C, V_{CC} = 3.6V, external reference



33.2.9 Oscillator Characteristics

33.2.9.1 Ultra Low-Power Internal Oscillator

Figure 33-144. Ultra Low-Power Internal Oscillator Frequency vs. Temperature



33.2.9.2 32.768kHz Internal Oscillator

Figure 33-145. 32.768kHz Internal Oscillator Frequency vs. Temperature

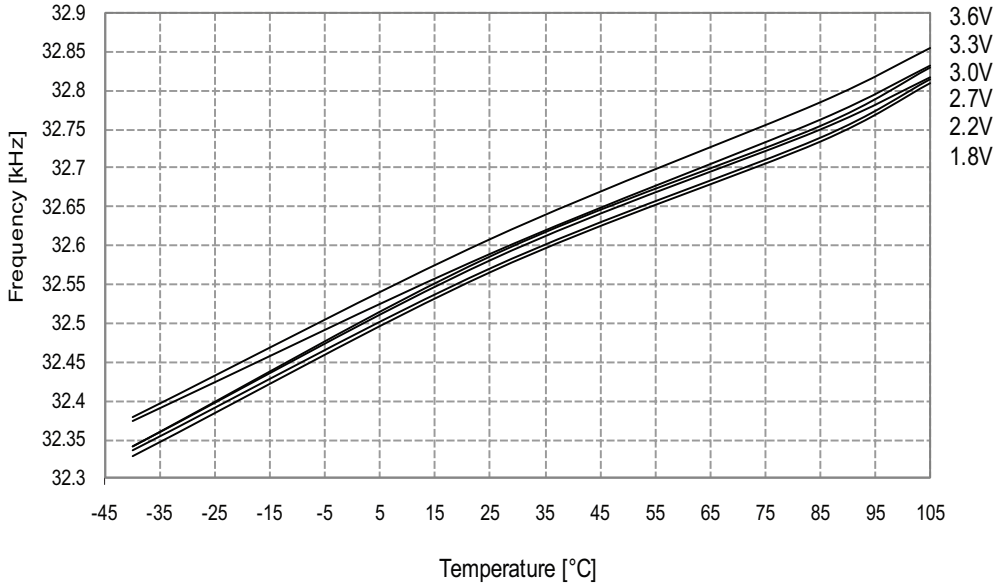


Figure 33-223. Reset Pin Pull-up Resistor Current vs. Reset Pin Voltage

V_{CC} = 3.3V

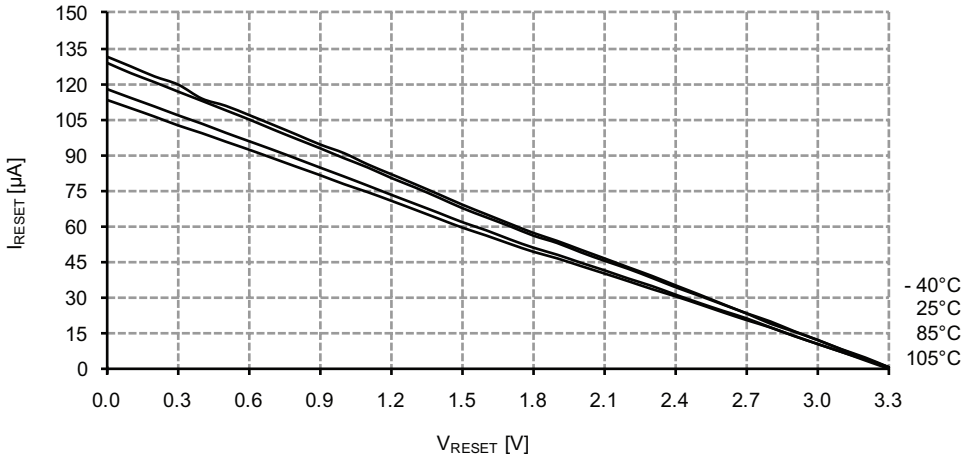


Figure 33-224. Reset Pin Input Threshold Voltage vs. V_{CC}

V_{IH} - Reset pin read as "1"

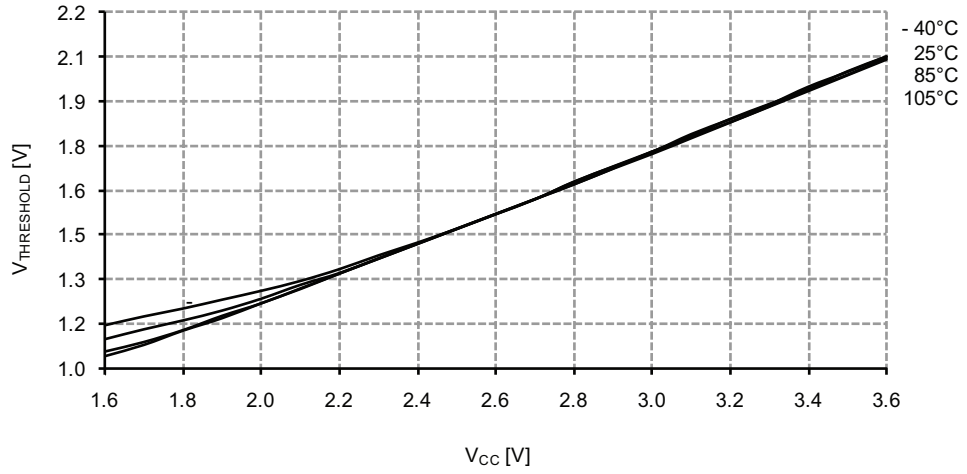
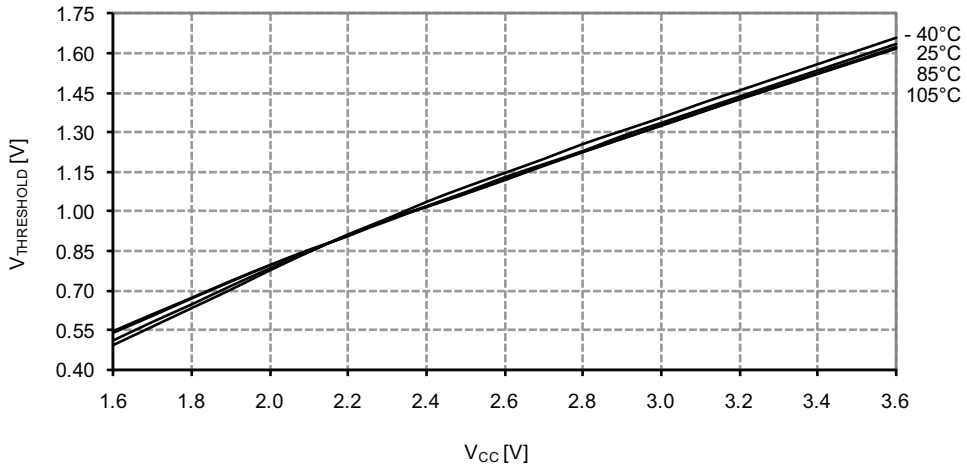


Figure 33-225. Reset Pin Input Threshold Voltage vs. V_{CC}

V_{IL} - Reset pin read as "0"



33.3.9 Power-on Reset Characteristics

Figure 33-226. Power-on Reset Current Consumption vs. V_{CC}

BOD level = 3.0V, enabled in continuous mode

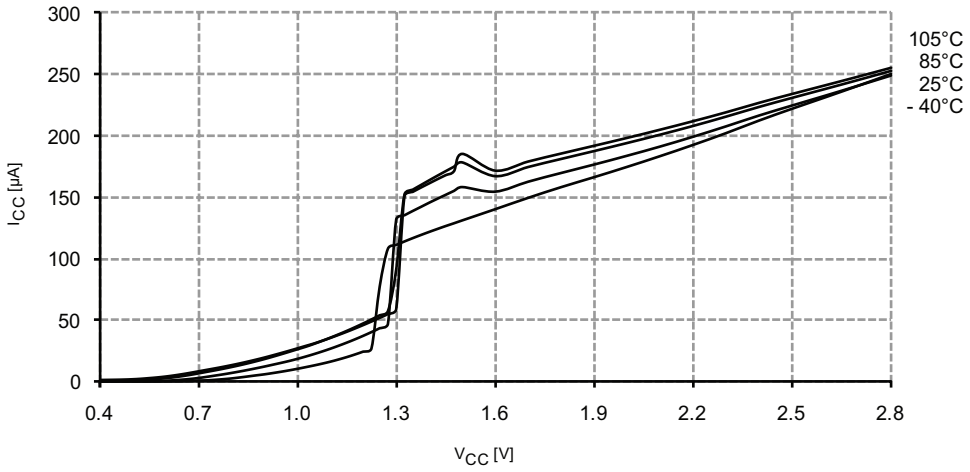
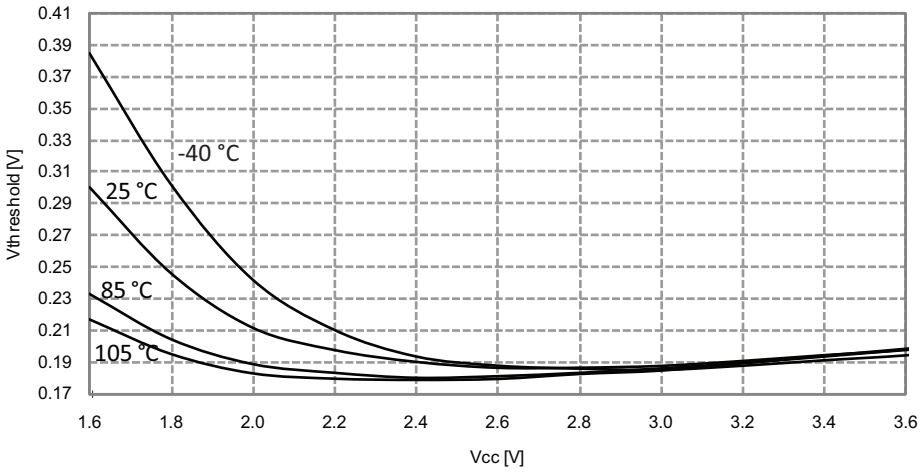


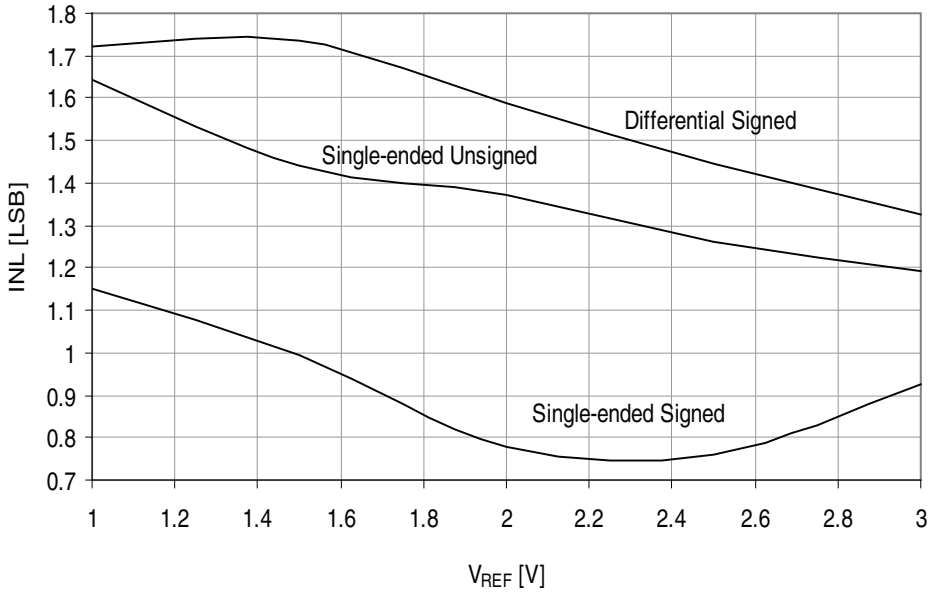
Figure 33-277. I/O Pin Input Hysteresis vs. V_{CC}



33.4.3 ADC Characteristics

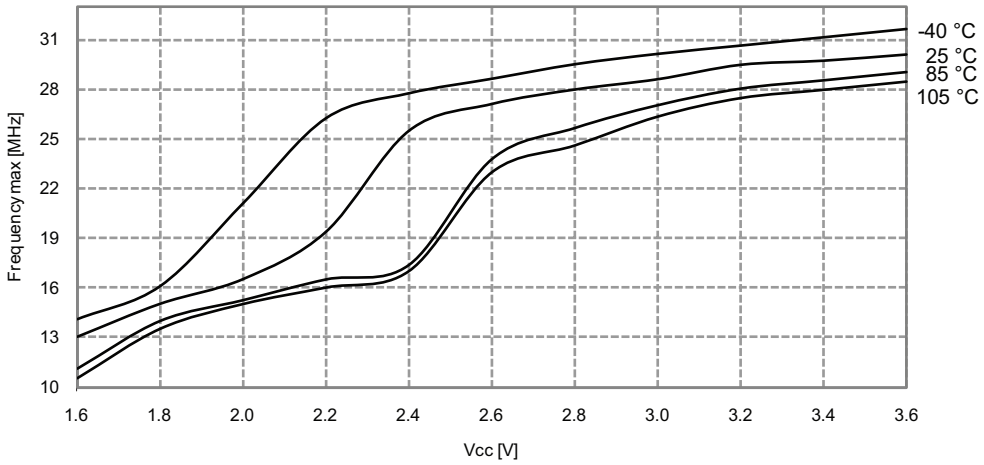
Figure 33-278. INL Error vs. External V_{REF}

T = 25°C, V_{CC} = 3.6V, external reference



33.4.12 PDI Characteristics

Figure 33-325. Maximum PDI Frequency vs. V_{CC}



Problem fix/Workaround

None for Output/Pull configuration.

For inverted I/O, configure the Analog Comparator to give an inverted result (i.e. connect positive input to the negative AC input and vice versa), or use and external inverter to change polarity of Analog Comparator output.

16. NMI Flag for Crystal Oscillator Failure automatically cleared

NMI flag for Crystal Oscillator Failure (XOSCFDIF) will be automatically cleared when executing the NMI interrupt handler

Problem fix/Workaround

This device revision has only one NMI interrupt source, so checking the interrupt source in software is not required

17. Flash Power Reduction Mode can not be enabled when entering sleep

If Flash Power Reduction Mode is enabled when entering Power-save or Extended Standby sleep mode, the device will only wake up on every fourth wake-up request. If Flash Power Reduction Mode is enabled when entering Idle sleep mode, the wake-up time will vary with up to 16 CPU clock cycles.

Problem fix/Workaround

Disable Flash Power Reduction mode before entering sleep mode.

18. Crystal start-up time required after power-save even if crystal is source for RTC

Even if 32.768 kHz crystal is used for RTC during sleep, the clock from the crystal will not be ready for the system before the specified start-up time. See "XOSCSEL[3:0]: Crystal Oscillator Selection " in XMEGA A Manual. If BOD is used in active mode, the BOD will be on during this period (0.5s).

Problem fix/Workaround

If faster start-up is required, go to sleep with internal oscillator as system clock

19. RTC Counter value not correctly read after sleep

If the RTC is set to wake up the device on RTC Overflow and bit 0 of RTC CNT is identical to bit 0 of RTC PER as the device is entering sleep, the value in the RTC count register can not be read correctly within the first prescaled RTC clock cycle after wakeup. The value read will be the same as the value in the register when entering sleep.

The same applies if RTC Compare Match is used as wake-up source.

Problem fix/Workaround

Wait at least one prescaled RTC clock cycle before reading the RTC CNT value.

20. Pending asynchronous RTC-interrupts will not wake up device

Asynchronous Interrupts from the Real-Time-Counter that is pending when the sleep instruction is executed, will be ignored until the device is woken from another source or the source triggers again.

Problem fix/Workaround

None.

21. TWI Transmit collision flag not cleared on repeated start

The TWI transmit collision flag should be automatically cleared on start and repeated start, but is only cleared on start.

Problem fix/Workaround

Clear the flag in software after address interrupt.